Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
10/533,209	SHIH, CHIA SHUN		
Examiner	Art Unit		

Jane Rhee

1745

SEARCHED				
Class	Subclass	Date	Examiner	
428	113,40.1	3/13/2007	JR	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
East Search		3/13/2007	JR
Inventor Search		3/13/2007	JR
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